

BLF4G10LS-120

UHF power LDMOS transistor

Rev. 01 — 10 January 2006

Product data sheet

1. Product profile

1.1 General description

120 W LDMOS power transistor for base station applications at frequencies from 800 MHz to 1000 MHz.

Table 1: Typical performance

f = 920 MHz to 960 MHz; $T_h = 25^\circ\text{C}$; in a class-AB production test circuit; typical values.

| Mode of operation | V _{DS} (V) | P _L (W) | G _p (dB) | η_D (%) | ACPR ₄₀₀ (dBc) | ACPR ₆₀₀ (dBc) | EVM (%) | IMD3 (dBc) |
|-------------------|------------------------|-----------------------|------------------------|-----------------|------------------------------|------------------------------|------------|---------------|
| CW | 28 | 120 | 19 | 57 | - | - | - | - |
| GSM EDGE | 28 | 48 (AV) | 19 | 40 | -61 [1] | -72 [2] | 1.5 | - |
| 2-tone | 28 | 120 (PEP) | 19 | 46 | - | - | - | -31 |

[1] ACPR₄₀₀ at 30 kHz resolution bandwidth

[2] ACPR₆₀₀ at 30 kHz resolution bandwidth

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

- Typical GSM EDGE performance at a frequency of 920 MHz and 960 MHz, a supply voltage of 28 V and an I_{DQ} of 650 mA
 - ◆ Load power = 48 W (AV)
 - ◆ Gain = 19 dB (typ)
 - ◆ Efficiency = 40 % (typ)
 - ◆ ACPR₄₀₀ = -61 dBc (typ)
 - ◆ ACPR₆₀₀ = -72 dBc (typ)
 - ◆ EVM_{rms} = 1.5 % (typ)
- Easy power control
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (800 MHz to 1000 MHz)
- Internally matched for ease of use

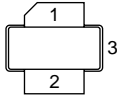
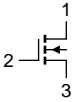
PHILIPS

1.3 Applications

- RF power amplifiers for GSM, GSM EDGE and CDMA base stations and multicarrier applications in the 868 MHz to 961 MHz frequency range.

2. Pinning information

Table 2: Pinning

| Pin | Description | Simplified outline | Symbol |
|-----|-------------|---|---|
| 1 | drain |  |  sym039 |
| 2 | gate | | |
| 3 | source | | |

[1] Connected to flange

3. Ordering information

Table 3: Ordering information

| Type number | Package | | |
|---------------|---------|---|---------|
| | Name | Description | Version |
| BLF4G10LS-120 | - | earless flanged LDMOST ceramic package; 2 leads | SOT502B |

4. Limiting values

Table 4: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------|----------------------|------------|------|------|------|
| V_{DS} | drain-source voltage | | - | 65 | V |
| V_{GS} | gate-source voltage | | -0.5 | +15 | V |
| I_D | drain current | | - | 12 | A |
| T_{stg} | storage temperature | | -65 | +150 | °C |
| T_j | junction temperature | | - | 200 | °C |

5. Thermal characteristics

Table 5: Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------|--|---------------------------|-----|------|------|------|
| $R_{th(j-case)}$ | thermal resistance from junction to case | $T_{case} = 80\text{ °C}$ | | | | |
| | | $P_L = 60\text{ W}$ | - | 0.62 | 0.71 | K/W |
| | | $P_L = 120\text{ W}$ | - | 0.52 | 0.61 | K/W |

6. Characteristics

Table 6: Characteristics

$T_j = 25^\circ\text{C}$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------|----------------------------------|--|------|------|------|------------------|
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $V_{GS} = 0\text{ V}; I_D = 0.9\text{ mA}$ | 65 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $V_{DS} = 10\text{ V}; I_D = 180\text{ mA}$ | 2.5 | 3.1 | 3.5 | V |
| V_{GSq} | gate-source quiescent voltage | $V_{DS} = 28\text{ V}; I_D = 900\text{ mA}$ | 2.70 | 3.20 | 3.70 | V |
| I_{DSS} | drain leakage current | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$ | - | - | 2.5 | μA |
| I_{DSX} | drain cut-off current | $V_{GS} = V_{GS(th)} + 9\text{ V};$ $V_{DS} = 10\text{ V}$ | 27 | 30 | - | A |
| I_{GSS} | gate leakage current | $V_{GS} = 15\text{ V}; V_{DS} = 0\text{ V}$ | - | - | 300 | nA |
| g_{fs} | forward transconductance | $V_{DS} = 10\text{ V}; I_D = 10\text{ A}$ | - | 9.0 | - | S |
| $R_{DS(on)}$ | drain-source on-state resistance | $V_{GS} = V_{GS(th)} + 6\text{ V};$ $I_D = 6\text{ A}$ | - | 90 | - | $\text{m}\Omega$ |
| C_{rs} | feedback capacitance | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V};$ $f = 1\text{ MHz}$ | - | 2.5 | - | pF |

7. Application information

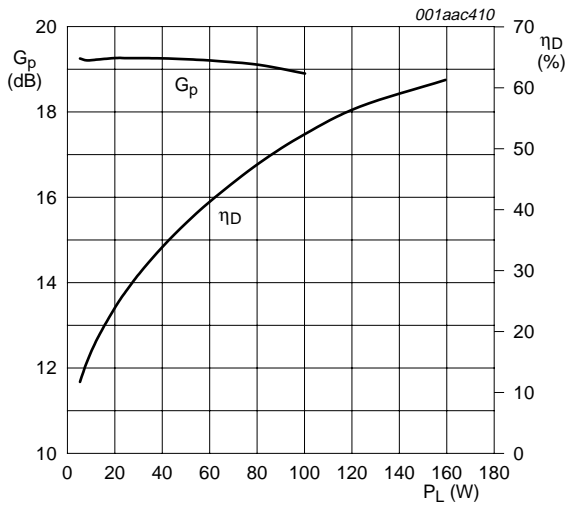
Table 7: Application information

Mode of operation: GSM EDGE; $f = 920\text{ MHz}$ and 960 MHz ; RF performance at $V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25^\circ\text{C}$; unless otherwise specified, in a class AB production test circuit.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---------------------|--|---------------------------|------|------|------|------|
| G_p | power gain | $P_{L(AV)} = 48\text{ W}$ | 17.5 | 19 | - | dB |
| IRL | input return loss | $P_{L(AV)} = 48\text{ W}$ | - | -8.0 | -5.5 | dB |
| η_D | drain efficiency | $P_{L(AV)} = 48\text{ W}$ | 35.8 | 40 | - | % |
| ACPR ₄₀₀ | adjacent channel power ratio (400 kHz) | $P_{L(AV)} = 48\text{ W}$ | - | -61 | -58 | dBc |
| ACPR ₆₀₀ | adjacent channel power ratio (600 kHz) | $P_{L(AV)} = 48\text{ W}$ | - | -72 | -68 | dBc |
| EVM _{rms} | rms EDGE signal distortion error | $P_{L(AV)} = 48\text{ W}$ | - | 1.5 | 2.5 | % |
| EVM _M | peak EDGE signal distortion error | $P_{L(AV)} = 48\text{ W}$ | - | 5 | 8.5 | % |

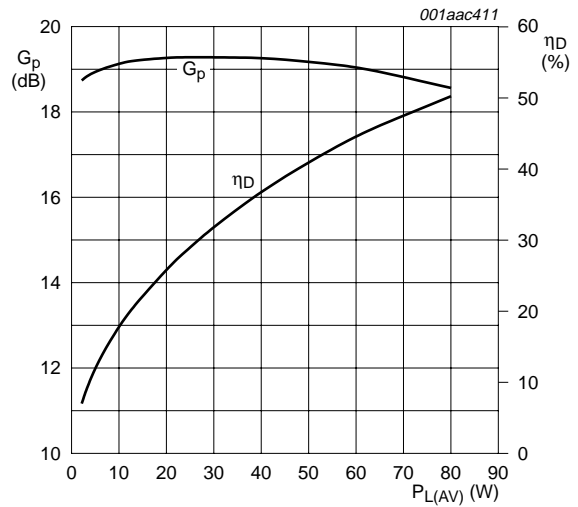
7.1 Ruggedness in class-AB operation

The BLF4G10LS-120 is capable of withstanding a load mismatch corresponding to $V_{SWR} = 10 : 1$ through all phases under the following conditions: $V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $P_L = 120\text{ W}$ (CW); $f = 960\text{ MHz}$.



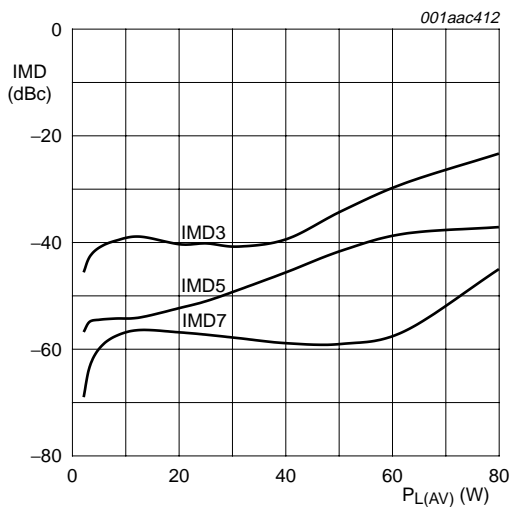
$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

Fig 1. One-tone CW power gain and drain efficiency as functions of load power; typical values



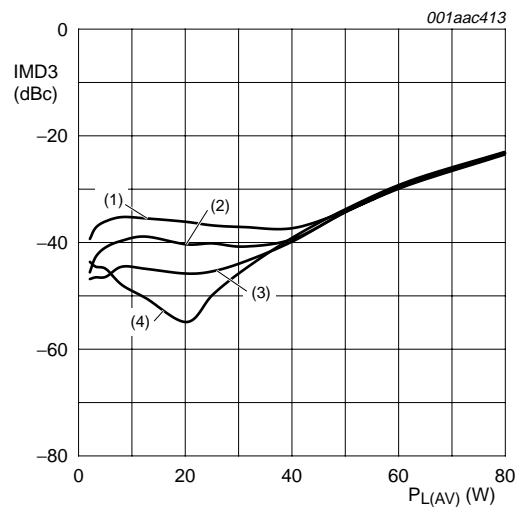
$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

Fig 2. Two-tone CW power gain and drain efficiency as functions of average load power; typical values



$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

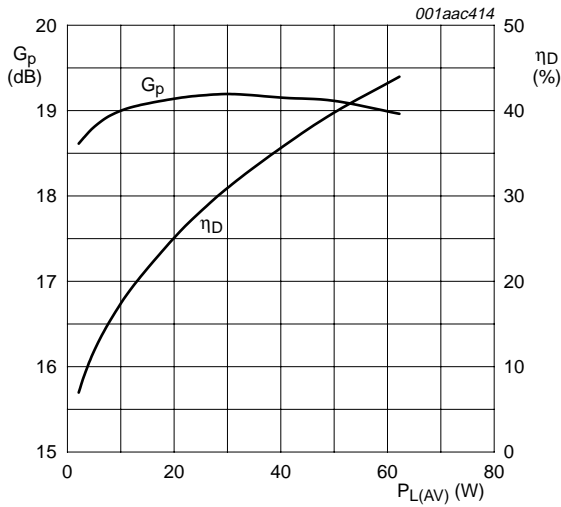
Fig 3. Intermodulation distortion as a function of average load power; typical values



$V_{DS} = 28\text{ V}$; $T_{case} = 25\text{ }^\circ\text{C}$; $f = 960\text{ MHz}$

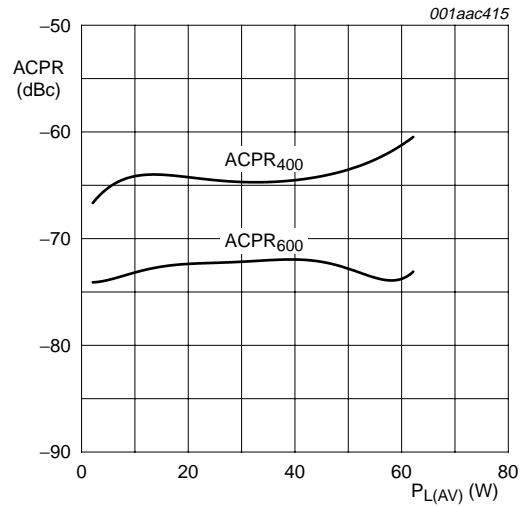
- (1) $I_{Dq} = 550\text{ mA}$
- (2) $I_{Dq} = 650\text{ mA}$
- (3) $I_{Dq} = 750\text{ mA}$
- (4) $I_{Dq} = 850\text{ mA}$

Fig 4. Third order intermodulation distortion as a function of average load power; typical values



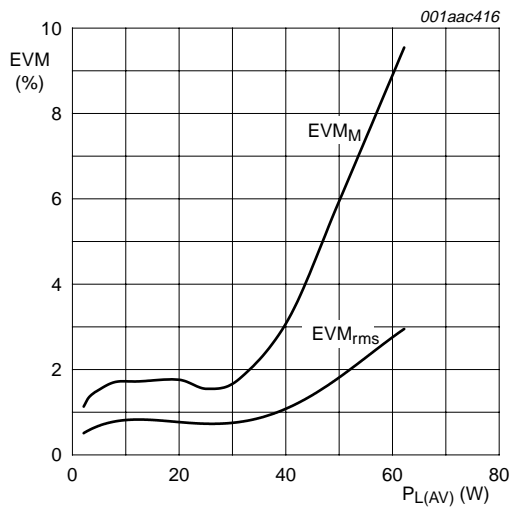
$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

Fig 5. GSM EDGE power gain and drain efficiency as functions of average load power; typical values



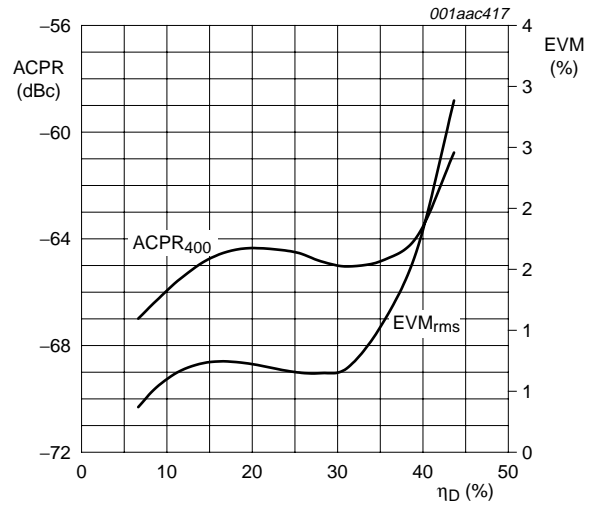
$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

Fig 6. GSM EDGE ACPR at 400 kHz and at 600 kHz as a function of average load power; typical values



$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

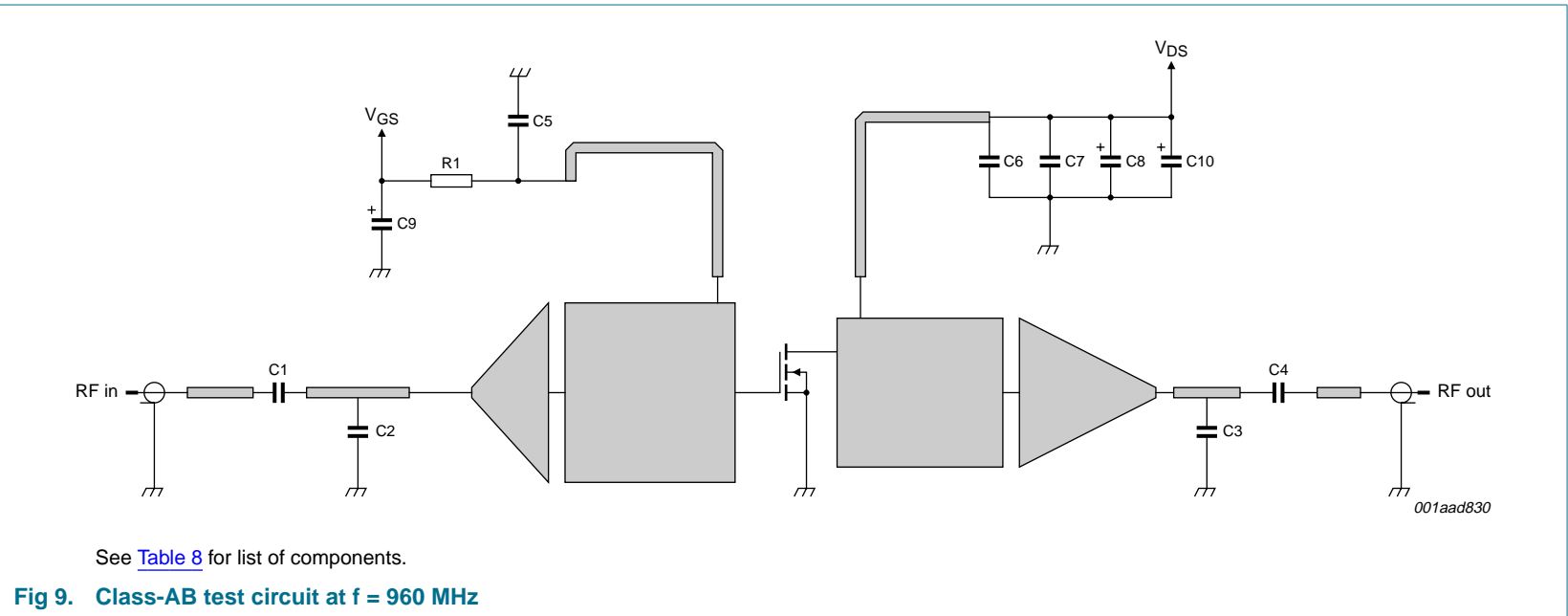
Fig 7. GSM EDGE rms EVM and peak EVM as functions of average load power; typical values

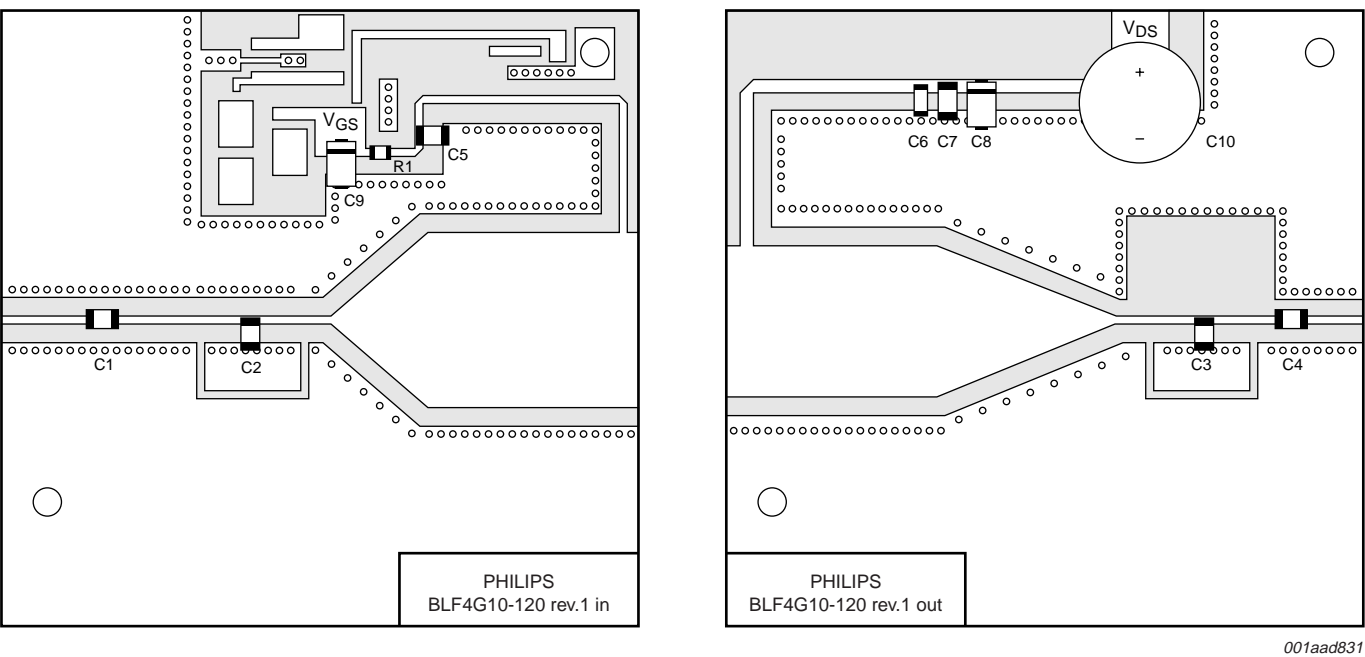


$V_{DS} = 28\text{ V}$; $I_{Dq} = 650\text{ mA}$; $T_{case} = 25\text{ }^\circ\text{C}$;
 $f = 960\text{ MHz}$

Fig 8. GSM EDGE ACPR at 400 kHz and rms EVM as functions of drain efficiency; typical values

8. Test information





Striplines are on a double copper-clad Rogers 6006 Printed-Circuit Board (PCB) ($\epsilon_r = 6.2$); thickness = 0.025 inches.
See [Table 8](#) for list of components.

Fig 10. Component layout for 960 MHz test circuit

Table 8: List of components (see [Figure 9](#) and [Figure 10](#))

| Component | Description | Value | Dimensions | Catalogue number |
|----------------|-----------------------------------|------------------|------------|------------------|
| C1, C4, C5, C6 | multilayer ceramic chip capacitor | [1] 68 pF | | |
| C2 | multilayer ceramic chip capacitor | [1] 5.1 pF | | |
| C3 | multilayer ceramic chip capacitor | [1] 3.0 pF | | |
| C7 | multilayer ceramic chip capacitor | 1 μ F | | 1812X7R105KL2AB |
| C8, C9 | tantalum capacitor | 10 μ F; 35 V | | |
| C10 | Philips electrolytic capacitor | 220 μ F | | |
| R1 | Philips chip resistor | 5.1 Ω | 0603 | |

[1] American Technical Ceramics type 100B or capacitor of same quality.

9. Package outline

Earless flanged LDMOST ceramic package; 2 leads

SOT502B

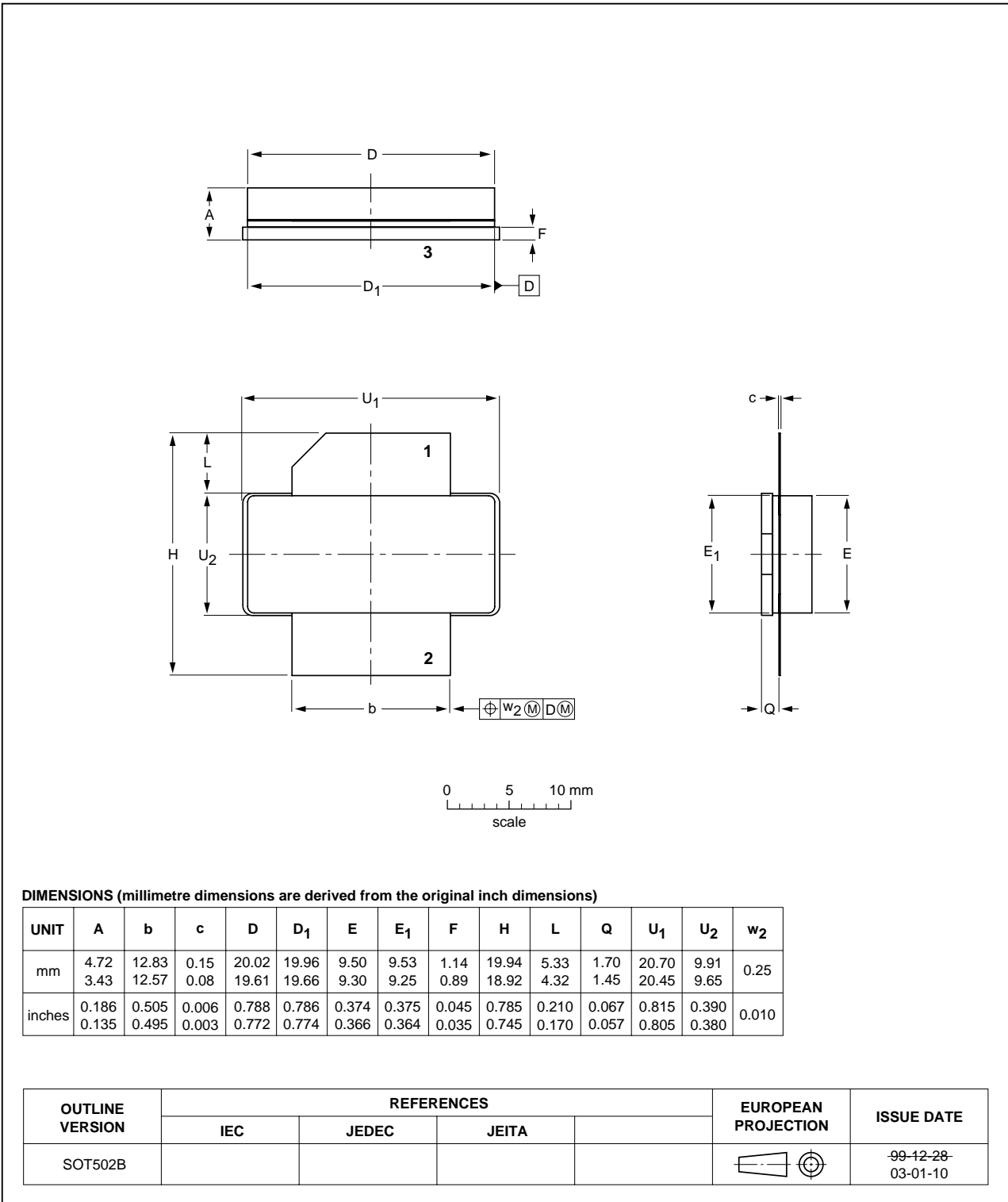


Fig 11. Package outline SOT502B

10. Abbreviations

Table 9: Abbreviations

| Acronym | Description |
|----------|--|
| CDMA | Code Division Multiple Access |
| CW | Continuous Wave |
| EDGE | Enhanced Data rates for GSM Evolution |
| ESR | Equivalent Series Resistance |
| EVM | Error Vector Magnitude |
| GSM | Global System for Mobile communications |
| I_{Dq} | quiescent drain current |
| LDMOS | Laterally Diffused Metal Oxide Semiconductor |
| PEP | Peak Envelope Power |
| RF | Radio Frequency |
| SMD | Surface Mount Device |
| VSWR | Voltage Standing Wave Ratio |



11. Revision history

Table 10: Revision history

| Document ID | Release date | Data sheet status | Change notice | Doc. number | Supersedes |
|-----------------|--------------|--------------------|---------------|----------------|------------|
| BLF4G10LS-120_1 | 20060110 | Product data sheet | - | 9397 750 14547 | - |

12. Data sheet status

| Level | Data sheet status ^[1] | Product status ^{[2] [3]} | Definition |
|-------|----------------------------------|-----------------------------------|--|
| I | Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice. |
| II | Preliminary data | Qualification | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product. |
| III | Product data | Production | This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). |

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

13. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

14. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors

16. Contact information

For additional information, please visit: <http://www.semiconductors.philips.com>

For sales office addresses, send an email to: sales.addresses@www.semiconductors.philips.com

customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

15. Trademarks

Notice — All referenced brands, product names, service names and trademarks are the property of their respective owners.

17. Contents

| | | |
|-----------|--|-----------|
| 1 | Product profile | 1 |
| 1.1 | General description | 1 |
| 1.2 | Features | 1 |
| 1.3 | Applications | 2 |
| 2 | Pinning information | 2 |
| 3 | Ordering information | 2 |
| 4 | Limiting values | 2 |
| 5 | Thermal characteristics | 2 |
| 6 | Characteristics | 3 |
| 7 | Application information | 3 |
| 7.1 | Ruggedness in class-AB operation | 3 |
| 8 | Test information | 6 |
| 9 | Package outline | 9 |
| 10 | Abbreviations | 10 |
| 11 | Revision history | 11 |
| 12 | Data sheet status | 12 |
| 13 | Definitions | 12 |
| 14 | Disclaimers | 12 |
| 15 | Trademarks | 12 |
| 16 | Contact information | 12 |



© Koninklijke Philips Electronics N.V. 2006

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

Date of release: 10 January 2006
Document number: 9397 750 14547

Published in The Netherlands